A Print Format

♥IEEE TEEE HOME : SEARCH TEEE | SHOP | WEB ACCOUNT | CONTACT TEEE Publications/Services Standards Membership Conferences Welcome United States Patent and Trademark Office Search Results <u>FAQ</u> Terms IEEE Quick Links ∇ Help Peer Review Welcome to IEEE Xolore Your search matched 5 of 953242 documents. O- Home O- What Can A maximum of 5 results are displayed, 25 to a page, sorted by Relevance in descending I Access? O- Log-out You may refine your search by editing the current search expression or entering a new one Tables of Contents \$the text box. O- Journals & Magazines Then click **Search Again**. (set breakpoint) Conference Proceedings Search Again Cr Standards Results: Search Journal or Magazine = JNL Conference = CNF Standard = STD O- By Author O-Basic 1 Ddbx-LPP: a dynamic software tool for debugging O- Advanced asynchronous distributed algorithms on loosely-coupled Member Services parallel processors O- Join IEEE Fernandez, M.G.; Ghosh, S.; C Establish IEEE Systems, Man, and Cybernetics, 1991. 'Decision Aiding for Complex Web Account Systems, Conference Proceedings., 1991 IEEE International O- Access the Conference on , 13-16 Oct. 1991 IEEE Member Page(s): 639 -644 vol.1 Digital Library

[Abstract] [PDF Full-Text (572 KB)] **IEEE CNF**

2 System validation by source level emulation of behavioral VHDL specifications

Koch, G.; Kebschull, U.; Rosenstiel, W.; Rapid System Prototyping, 1995. Proceedings., Sixth IEEE International Workshop on , 7-9 June 1995

Page(s): 210 -216

[Abstract] [PDF Full-Text (584 KB)] IEEE CNF

3 VHdbx: an X window system based high-level debugger for the VHDL simulation environment

Bo Wan; Jinian Bian;

Solid-State and Integrated Circuit Technology, 1995 4th International

Conference on , 24-28 Oct. 1995

Page(s): 358 -360

[Abstract] [PDF Full-Text (192 KB)] IEEE CNF

4 Debugging of behavi ral VHDL specifications by s urce level emulation

Koch, G.; Kebschull, U.; Rosenstiel, W.; Design Automation Conference, 1995, with EURO-VHDL, Proceedings EURO-DAC '95., European , 18-22 Sept. 1995 Page(s): 256 -261

[Abstract] [PDF Full-Text (540 KB)] IEEE CNF

5 Co-emulation and debugging of HW/SW-systems

Koch, G.; Kebschull, U.; Rosenstiel, W.; System Synthesis, 1997. Proceedings., Tenth International Symposium on , 17-19 Sept. 1997 Page(s): 120 -125

[Abstract] [PDF Full-Text (544 KB)] IEEE CNF

Home | Log-out | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search | Join IEEE | Web Account | New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No Robots Please | Release Notes | IEEE Online Publications | Help | FAQ | Terms | Back to Top

Copyright © 2003 IEEE — All rights reserved

◆IEEE IEEE HOME : SEARCH IEEE | SHOP | WEB ACCOUNT | CONTACT IEEE Publications/Services Standards Membership Conferences Careersilobs Welcome United States Patent and Trademark Office **611** 8 8 8 1 5 Search Results Help FAQ Terms IEEE Quick Links Peer Review Welcome to IEEE Aplors: Your search matched 1 of 955082 documents. C Home O- What Can A maximum of 1 results are displayed, 15 to a page, sorted by Relevance in descending ACCESS? O- Log-out You may refine your search by editing the current search expression or entering a new one Tables of Contents the text box. O- Journals & Magazines Then click **Search Again**. (global breakpoints <in> ti) Conference Proceedings Search Again O Standards Results: Search Journal or Magazine = JNL Conference = CNF Standard = STD O- By Author ∩- Basic 1 Global events and global breakpoints in distributed systems O- Advanced Haban, D.; Weigel, W.; Member Services System Sciences, 1988. Vol.II. Software Track, Proceedings of the Twenty-First Annual Hawaii International Conference on , Volume: 2, O- Join IEEE C Establish IEEE 5-8 Jan. 1988 Web Account Page(s): 166 -175 Access the IEEE Member Digital Library [Abstract] [PDF Full-Text (812 KB)] IEEE CNF 🖴 Prior Format

Home | Log-out | Journals | Conference Proceedings | Standards | Search by Author | Basic Search | Advanced Search | Join IEEE | Web Account | New this week | OPAC Linking Information | Your Feedback | Technical Support | Email Alerting | No Robots Please | Release Notes | IEEE Online Publications | Help | FAQ | Terms | Back to Top

Copyright © 2003 IEEE - All rights reserved